L Number	Hits	Search Text	DB	Time stamp
7	1	(direct\$2 near3 processor) near8 ((test\$3	JPO;	2004/06/18 09:28
'	1	or diagnostic) adj2 (card or device or tool or apparatus))	IBM_TDB	
5	11	(direct\$2 near3 processor) near8 ((test\$3 or diagnostic) adj2 (card or device or	USPAT	2004/06/18 09:28
6	1	tool or apparatus)) (direct\$2 near3 processor) near8 ((test\$3 or diagnostic) adj2 (card or device or	EPO; DERWENT	2004/06/18 09:28
_	2	tool or apparatus)) "20020104040"	US-PGPUB;	2004/06/17 11:05
_	1	"6751569"	DERWENT USPAT	2004/06/16 11:00
_	6	("5388267"   "5423029"   "5535330"   "5823818"   "5854937"   "5875293").PN.	USPAT	2004/06/16 15:56
-	11 2	5875293.URPN. detect\$3 near5 (coupl\$2 or connect\$2) with	USPAT USPAT	2004/06/16 17:38 2004/06/16 17:40
-	2	<pre>initiat\$3 with (test\$3 adj1 apparatus) detect\$3 near5 (coupl\$2 or connect\$2) with initiat\$3 with (test\$3 adj1 apparatus)</pre>	EPO; JPO; DERWENT;	2004/06/16 17:15
_	780	manufacture near1 mode	IBM_TDB USPAT; US-PGPUB	2004/06/16 17:15
-	0	(manufacture near1 mode) and initial\$5	EPO; JPO; DERWENT;	2004/06/16 17:21
-	4	(manufacture near1 mode) with initial\$5	IBM_TDB USPAT; US-PGPUB	2004/06/16 17:19
_	39	manufacture near1 mode	EPO; JPO; DERWENT; IBM TDB	2004/06/16 17:21
_	15	(manufacture near1 mode) same initial\$5	USPAT; US-PGPUB	2004/06/16 17:32
_	4	(manufactur\$3 near1 mode) and initial\$5	EPO; JPO; DERWENT; IBM TDB	2004/06/16 17:24
-	0	(manufactur\$3 near1 mode) and initiat\$5	EPO; JPO; DERWENT; IBM TDB	2004/06/16 17:25
_	0	(manufactur\$3 near1 mode) and initiat\$5	EPO; JPO; DERWENT; IBM TDB	2004/06/16 17:32
_	96	manufactur\$3 near1 mode	EPO; JPO; DERWENT; IBM TDB	2004/06/16 17:27
-	40	<pre>manufactur\$3 near1 mode same (initiat\$3 or initial\$5)</pre>	USPAT	2004/06/16 17:29
	103	debugging nearl apparatus	USPAT USPAT	2004/06/16 17:29 2004/06/16 17:31
_	28	debugging adjl apparatus (debugging adjl apparatus) and chun.xa.	USPAT	2004/06/16 17:30
_	105	debugging adj1 apparatus	US-PGPUB; EPO; JPO; DERWENT;	2004/06/16 17:31
_	3	(debugging adjl apparatus) and initiat\$5	IBM_TDB EPO; JPO; DERWENT; IBM TDB	2004/06/16 17:32
	0	(debugging adjl apparatus) same initial\$5	USPAT; US-PGPUB	2004/06/16 17:32
_	107	<pre>(detect\$3 near5 (coupl\$3 or connect\$2)) with (test\$3 adj1 apparatus)</pre>	USPAT	2004/06/16 17:41
	5 4875	17.ab. huh.in.	USPAT US-PGPUB; DERWENT	2004/06/16 17:41 2004/06/17 11:05
	1 3065	huh.in. and boot near2 code (initiat\$3 or initializ\$5 or boot\$3) with (detect\$3) near4 (device\$1 or apparatus)	USPAT USPAT	2004/06/17 13:31 2004/06/17 14:25
-	3065	(detect\$3) near4 (device\$1 or apparatus) (initiat\$3 or initializ\$5 or boot\$3) with ((detect\$3) near4 (device\$1 or apparatus))	USPAT	2004/06/17 15:32
_	33	"5864698"	USPAT USPAT	2004/06/17 14:24 2004/06/17 14:24

_	1055	((initiat\$3 or initializ\$5 or boot\$3) with	USPAT	2004/06/17 14:26
		((detect\$3) near4 (device\$1 or		
		apparatus))) and (test\$3)		
	188	((initiat\$3 or initializ\$5 or boot\$3) with	USPAT	2004/06/17 14:28
		((detect\$3) near4 (device\$1 or		
		apparatus))) same (test\$3)		
1_	0	((initiat\$3 or initializ\$5 or boot\$3) with	EPO;	2004/06/17 14:26
		((detect\$3) near4 (device\$1 or	DERWENT	
		apparatus))) same (test\$3)		
l _	0	((initiat\$3 or initializ\$5 or boot\$3) with	JPO;	2004/06/17 14:26
		((detect\$3) near4 (device\$1 or	IBM TDB	
		apparatus))) same (test\$3)	1511_155	
	646	(initiat\$3 or initializ\$5 or boot\$3) with	EPO;	2004/06/17 14:28
_	040		DERWENT	2004/00/1/ 14.20
t	0.47	((detect\$3) near4 (device\$1 or apparatus))	JPO;	2004/06/17 14:28
_	247	(initiat\$3 or initializ\$5 or boot\$3) with	•	2004/06/1/ 14:20
		((detect\$3) near4 (device\$1 or apparatus))	IBM_TDB	0004/06/17 14:00
-	10	((initiat\$3 or initializ\$5 or boot\$3) with	JPO;	2004/06/17 14:28
		((detect\$3) near4 (device\$1 or	IBM_TDB	
		apparatus))) same test\$3		0004/05/55
-	33	((initiat\$3 or initializ\$5 or boot\$3) with	EPO;	2004/06/17 14:44
		((detect\$3) near4 (device\$1 or	DERWENT	
		apparatus))) same test\$3		
-	0	((initiat\$3 or initializ\$5 or boot\$3) with	USPAT	2004/06/17 14:29
		((detect\$3) near4 (device\$1 or		
		apparatus))) same (test\$3 near5 target)		
_	4	((initiat\$3 or initializ\$5 or boot\$3) with	USPAT	2004/06/17 14:29
		((detect\$3) near4 (device\$1 or		
		apparatus))) same (test\$3 near5 computer)		
-	5	(((initiat\$3 or initializ\$5 or boot\$3)	EPO;	2004/06/17 14:44
		with ((detect\$3) near4 (device\$1 or	DERWENT	
		apparatus))) same test\$3) and g06f\$.ipc.		
_	60	((initiat\$3 or initializ\$5 or boot\$3)	USPAT	2004/06/17 14:52
		near5 computer) with (detect\$3 near4 upon)		
_	35	(((initiat\$3 or initializ\$5 or boot\$3)	USPAT	2004/06/17 14:49
		near5 computer) with (detect\$3 near4	002777	2001,00,1, 11113
		upon)) and g06f\$.ipc.		
	22	(((initiat\$3 or initializ\$5 or boot\$3)	USPAT	2004/06/17 15:25
-	44	near5 computer) with (detect\$3 near4	ODIAL	2004/00/17 13.23
	.	upon)) and test\$3	EDO: TDO:	2004/06/17 14:52
-	4	((initiat\$3 or initializ\$5 or boot\$3)	EPO; JPO;	2004/06/1/ 14:52
		near5 computer) with (detect\$3 near4 upon)	DERWENT;	
			IBM_TDB	2004/06/13 15 05
-	10153	test\$3 near6 target	USPAT	2004/06/17 15:25
-	258	test\$3 near6 (target adj3 (computer or	USPAT	2004/06/17 15:31
-		card device))		
-	109	(test\$3 near6 (target adj3 (computer or	USPAT	2004/06/17 15:31
		card device))) and g06f\$.ipc.		
-	295	detect\$3 near8 (test\$3 adj2 (device\$1 or	USPAT	2004/06/18 09:23
		apparatus or computer\$1 or card\$1)) near9		į
		(connect\$3 or coupl\$3)		
-	17	detect\$3 near8 (test\$3 adj2 (device\$1 or	EPO	2004/06/17 15:53
		apparatus or computer\$1 or card\$1)) near9		
		(connect\$3 or coupl\$3)		
-	32	detect\$3 near8 (test\$3 adj2 (device\$1 or	JPO	2004/06/17 15:53
		apparatus or computer\$1 or card\$1)) near9		
		(connect\$3 or coupl\$3)		
_	168	detect\$3 near8 (test\$3 adj2 (device\$1 or	DERWENT;	2004/06/17 15:53
	100	apparatus or computer\$1 or card\$1)) near9	IBM TDB	20.00
		(connect\$3 or coupl\$3)	-2	
L	1	(connects) or confital	l	

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